

# MJ N-Channel Enhancement Mode Power MOSFET

## Description

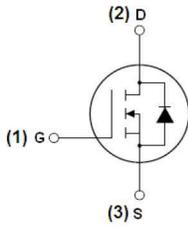
The MJ8295AK uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. This device is suitable for use in PWM, load switching and general purpose applications.

## General Features

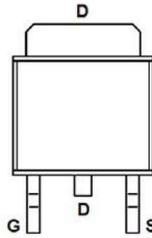
- ◆  $V_{DS} = 82V, I_D = 95A$   
 $R_{DS(ON)} < 8.0m\Omega @ V_{GS} = 10V$  (Typ: 6.6m $\Omega$ )
- ◆ High density cell design for ultra low  $R_{dson}$
- ◆ Fully characterized avalanche voltage and current
- ◆ Special designed for converters and power controls
- ◆ Good stability and uniformity with high  $E_{AS}$
- ◆ Excellent package for good heat dissipation
- ◆ Special process technology for high ESD capability

## Application

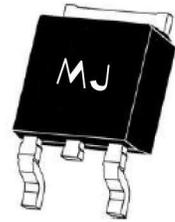
- ◆ Power switching application
- ◆ Hard switched and High frequency circuits
- ◆ Uninterruptible power supply



Schematic diagram



Marking and pin assignment



TO-252-2L top view

**100% UIS TESTED! 100%  $\Delta V_d$ s TESTED!**

## Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MJ8295AK	MJ8295AK	TO-252-2L	-	-	-

## Absolute Maximum Ratings ( $T_A = 25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	82	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current-Continuous	$I_D$	95	A
Drain Current-Continuous( $T_C = 100^\circ C$ )	$I_{D(100^\circ C)}$	67	A
Pulsed Drain Current	$I_{DM}$	320	A
Maximum Power Dissipation	$P_D$	170	W
Derating factor		1.13	W/ $^\circ C$
Single pulse avalanche energy <sup>(Note 5)</sup>	$E_{AS}$	529	mJ
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 To 175	$^\circ C$

## Thermal Characteristic

Thermal Resistance, Junction-to-Case <sup>(Note 2)</sup>	$R_{\theta JC}$	0.88	$^\circ C/W$
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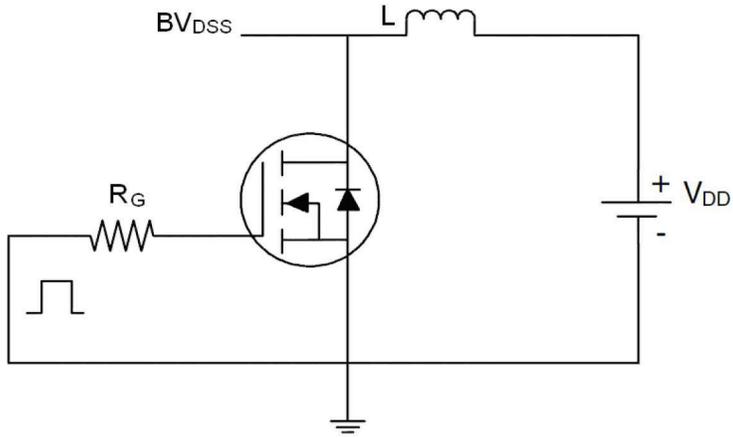
**Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)**

Parameter	Symbol	Condition	Min	Typ	Max	Unit
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	<b>BV<sub>DSS</sub></b>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	82	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =82V, V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =±20V, V <sub>GS</sub> =0V	-	-	±100	nA
<b>On Characteristics (Note 3)</b>						
Gate Threshold Voltage	<b>V<sub>GS(th)</sub></b>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	2	2.9	4	V
Drain-Source On-State Resistance	<b>R<sub>DS(ON)</sub></b>	V <sub>GS</sub> =10V, I <sub>D</sub> =20A	-	6.6	8.0	mΩ
Forward Transconductance	<b>g<sub>FS</sub></b>	V <sub>DS</sub> =5V, I <sub>D</sub> =20A	-	50	-	S
<b>Dynamic Characteristics (Note 4)</b>						
Input Capacitance	<b>C<sub>iss</sub></b>	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V F=1.0MHz	-	6800	-	PF
Output Capacitance	<b>C<sub>oss</sub></b>		-	353	-	PF
Reverse Transfer Capacitance	<b>C<sub>rss</sub></b>		-	261	-	PF
<b>Switching Characteristics (Note 4)</b>						
Turn-on Delay Time	<b>t<sub>d(on)</sub></b>	V <sub>DD</sub> =40V, R <sub>L</sub> =15Ω R <sub>G</sub> =2.5Ω, V <sub>GS</sub> =10V	-	18	-	nS
Turn-on Rise Time	<b>t<sub>r</sub></b>		-	12	-	nS
Turn-Off Delay Time	<b>t<sub>d(off)</sub></b>		-	56	-	nS
Turn-Off Fall Time	<b>t<sub>f</sub></b>		-	15	-	nS
Total Gate Charge	<b>Q<sub>g</sub></b>	V <sub>DS</sub> =40V, I <sub>D</sub> =50A V <sub>GS</sub> =10V	-	109.3	-	nC
Gate-Source Charge	<b>Q<sub>gs</sub></b>		-	35.1	-	nC
Gate-Drain Charge	<b>Q<sub>gd</sub></b>		-	25.8	-	nC
<b>Drain-Source Diode Characteristics</b>						
Diode Forward Voltage (Note 3)	<b>V<sub>SD</sub></b>	V <sub>GS</sub> =0V, I <sub>S</sub> =95A	-	-	1.2	V
Diode Forward Current (Note 2)	I <sub>S</sub>		-	-	95	A
Reverse Recovery Time	<b>t<sub>rr</sub></b>	T <sub>J</sub> =25°C, I <sub>F</sub> =100A di/dt=100A/μs (Note 3)	-	-	37	nS
Reverse Recovery Charge	<b>Q<sub>rr</sub></b>		-	-	58	nC

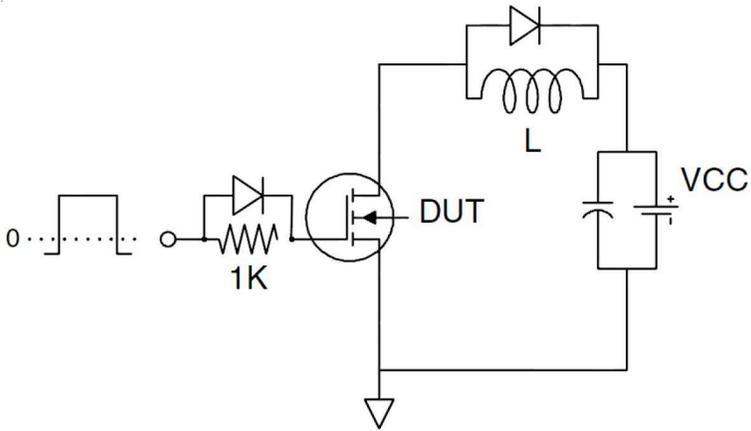
**Notes:**

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board, t ≤ 10 sec.
- ③ Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
- ④ Guaranteed by design, not subject to production
- ⑤ EAS condition: T<sub>J</sub>=25°C, V<sub>DD</sub>=40V, V<sub>G</sub>=10V, L=0.5mH, R<sub>G</sub>=25Ω

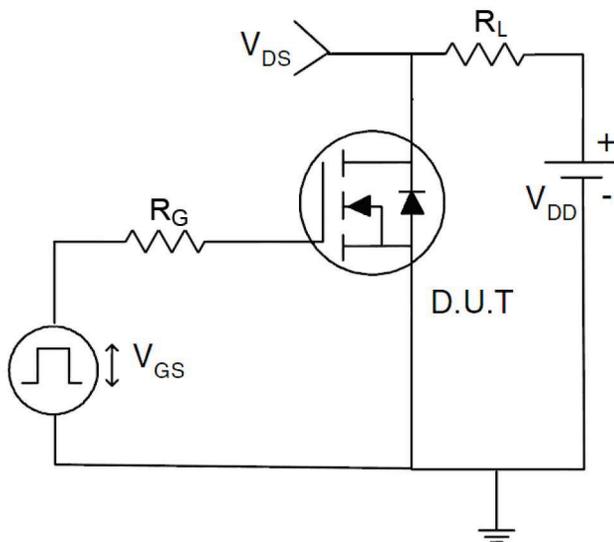
Test circuit



EAS test Circuit

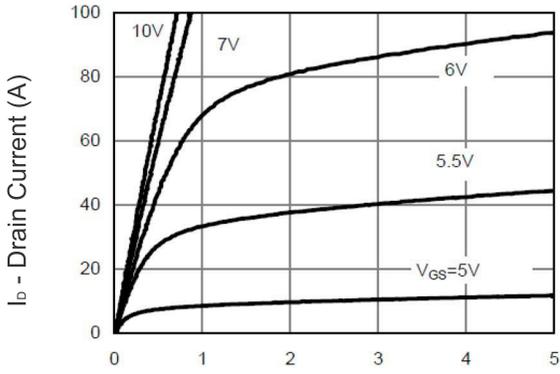


Gate charge test Circuit

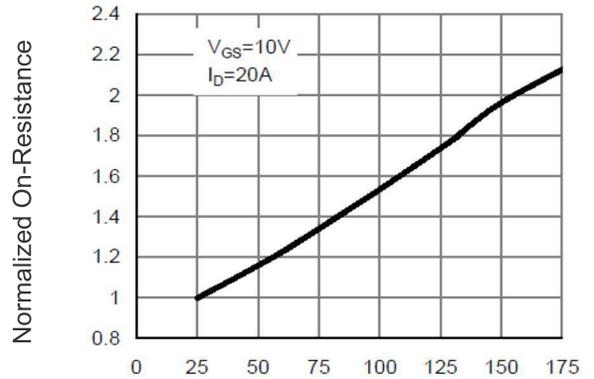


Switch Time Test Circuit

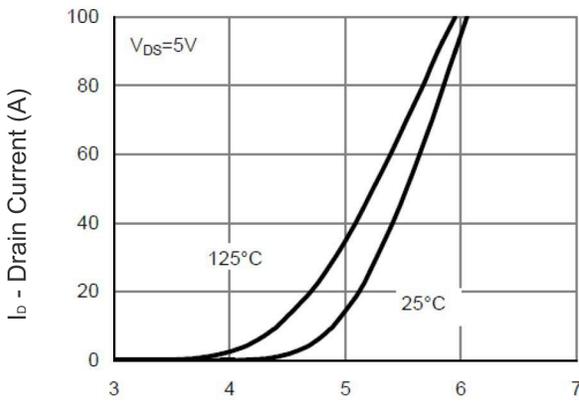
Typical Electrical and Thermal Characteristics (Curves)



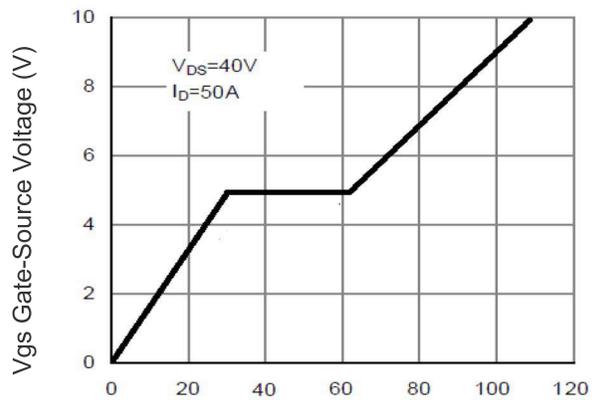
Vds Drain-Source Voltage (V)  
Figure 1 Output Characteristics



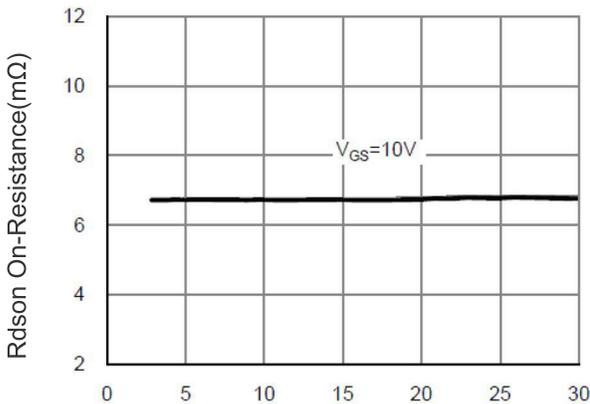
$T_J$  - Junction Temperature( $^{\circ}C$ )  
Figure 4  $R_{dson}$ -Junction Temperature



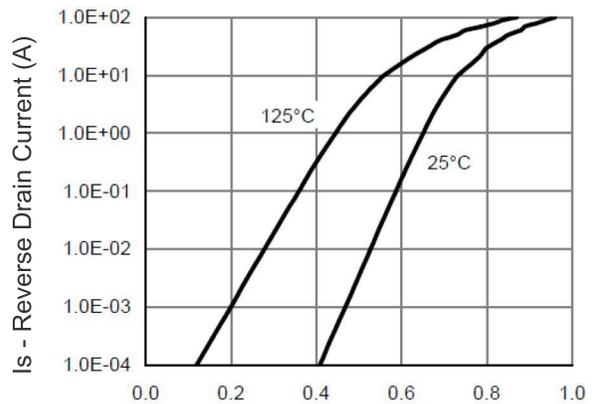
Vgs Gate-Source Voltage (V)  
Figure 2 Transfer Characteristics



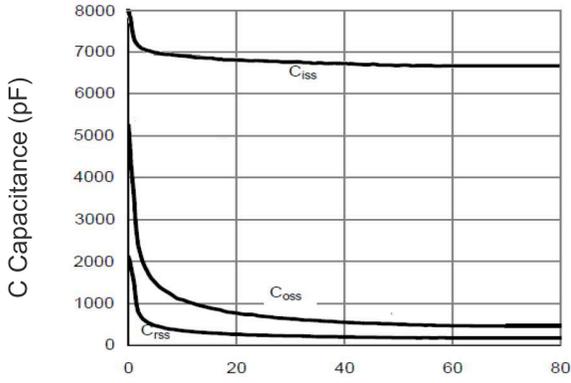
Qg Gate Charge (nC)  
Figure 5 Gate Charge



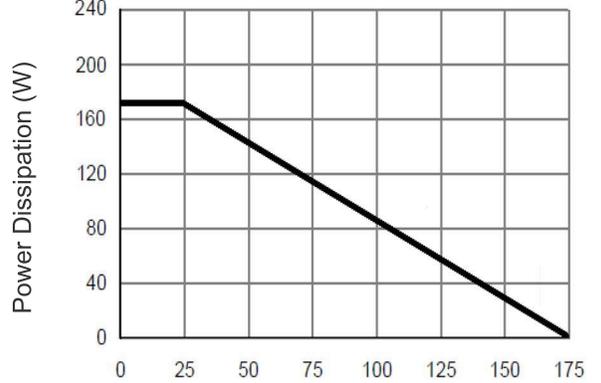
$I_D$  - Drain Current (A)  
Figure 3  $R_{dson}$ - Drain Current



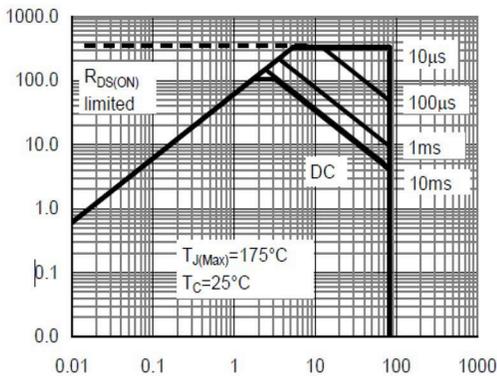
$V_{SD}$  Source-Drain Voltage (V)  
Figure 6 Source- Drain Diode Forward



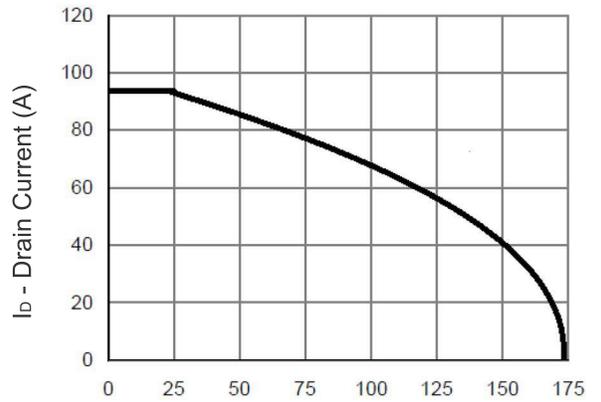
Vds Drain-Source Voltage (V)  
Figure 7 Capacitance vs Vds



TJ -Junction Temperature(°C)  
Figure 9 Power De-rating



Vds Drain-Source Voltage (V)  
Figure 8 Safe Operation Area



TJ -Junction Temperature(°C)  
Figure 10 Id Current De-rating

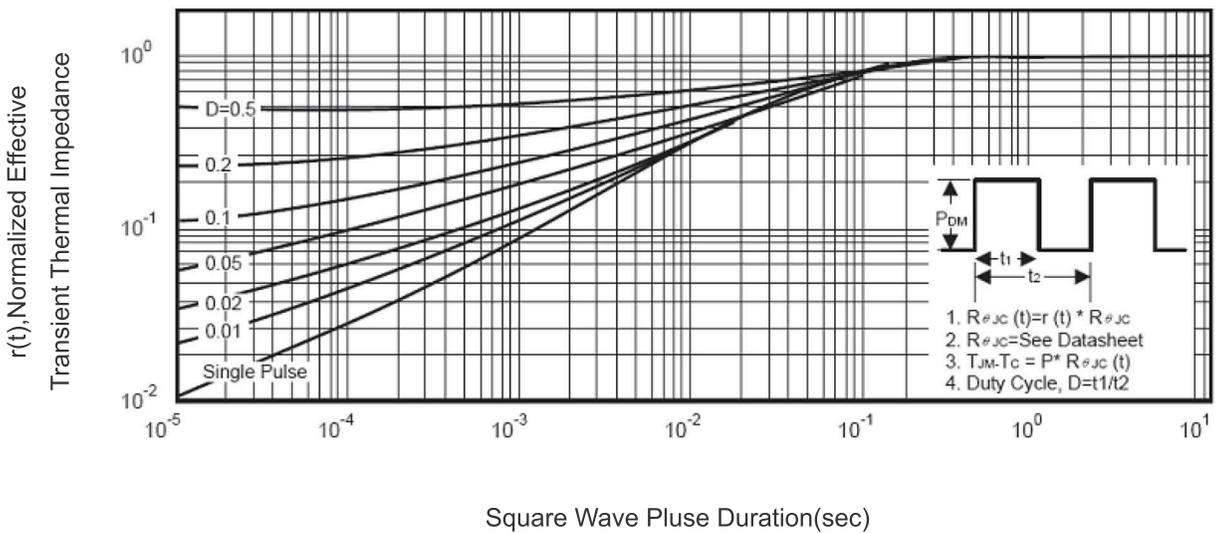
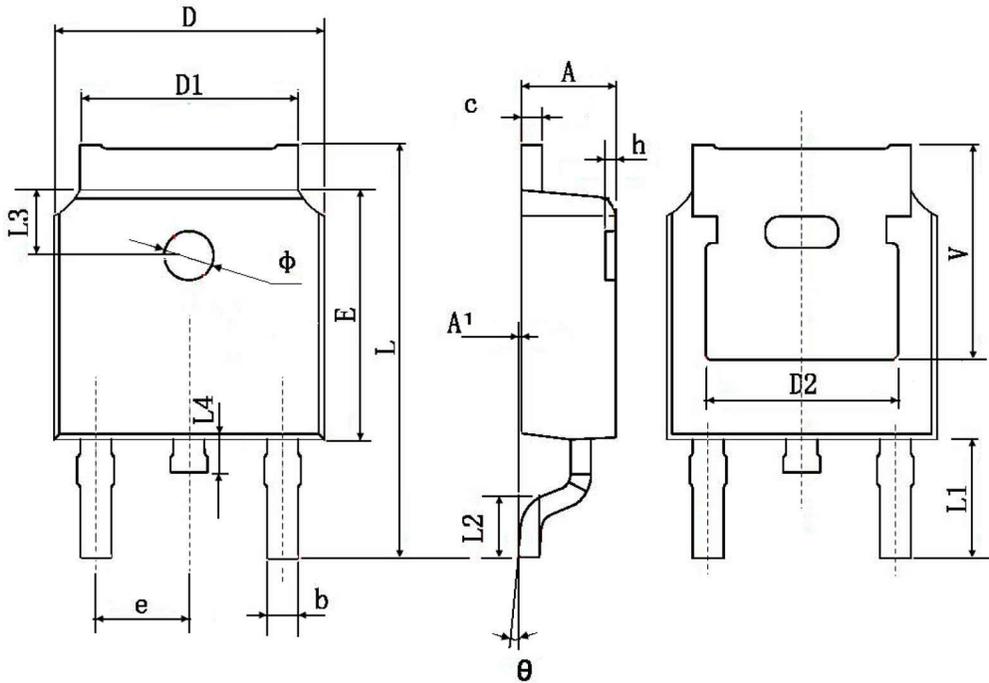


Figure 11 Normalized Maximum Transient Thermal Impedance

**TO-252 Package Information**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.660	0.860	0.026	0.034
c	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.830 TYP.		0.190 TYP.	
E	6.000	6.200	0.236	0.244
e	2.186	2.386	0.086	0.094
L	9.800	10.400	0.386	0.409
L1	2.900 TYP.		0.114 TYP.	
L2	1.400	1.700	0.055	0.067
L3	1.600 TYP.		0.063 TYP.	
L4	0.600	1.000	0.024	0.039
φ	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.350 TYP.		0.211 TYP.	

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